

FCC CFR47 PART 20.19 ANSI C63.19-2007

(Class II Permissive Change)

HAC RF EMISSIONS TEST REPORT

For

LTE Phone Bluetooth and WLAN

Model: US780, LG-US780, LGUS780 AS780, LG-AS780 and LGAS780 FCC ID: ZNFUS780

Report Number: 13U14853-2 Issue Date: 3/1/2013

Prepared for

LG ELECTRONICS MOBILECOMM U.S.A., INC. 1000 SYLVAN AVE. ENGLEWOOD CLIFFS, NJ 07632

Prepared by
UL CCS
47173 BENICIA STREET
FREMONT, CA 94538, U.S.A.

TEL: (510) 771-1000 FAX: (510) 661-0888



NVLAP LAB CODE 200065-0

Revision History

Rev.	Issue Date	Revisions	Revised By
	3/1/2013	Initial Issue	

TABLE OF CONTENTS

1.	Att	testation of Test Results	4
2.	Te	st Methodology	5
3.	Fa	cilities and Accreditation	5
4.	Ca	llibration and Uncertainty	6
4.	1.	Measuring Instrument Calibration	6
4.	2.	Measurement Uncertainty	7
5.	De	evice Under Test	8
5.	1.	List of Air Interfaces/Bands & Operating Modes	8
6.	Sy	stem Specifications	9
7.	Sy	stem Validation	10
7.	1.	System Validation Results	11
8.	Pro	obe Modulation Factor (PMF)	12
8.	1.	PMF Measurement Results	14
9.	HA	AC RF Emissions Test Procedure	15
10.	RF	Emissions Measurement Criteria	17
10	0.1.	. E-Field Emissions	17
10	0.2.	. H- Field Emissions	17
11.	Wo	orst-case Test Plots	18
12.	Ар	ppendixes	24
12	2.1.	. System Validation Plots	24
12	2.2.	. E-field emissions test plots	24
12	2.3.	. H-field emissions test plots	24
12	2.4.	. Calibration Certificate for E-Field Probe ER3DV6 - SN 2339	24
12	2.5.	Calibration Certificate for H-Field Probe H3DV6 - SN 6157	24
12	2.6.	. Calibration Certificate for Dipole CD835V3 - SN 1014	24
12	2.7.	Calibration Certificate for Dipole CD1880V3 - SN 1122	24
13.	Se	etup Photo	25

1. Attestation of Test Results

Applicant	LG ELECTRONICS MOBILECOMM U.S.A., INC.					
DUT description	LTE Phone Bluetooth	and WLAN				
Model	US780, LG-US780, LC	GUS780 AS780, LG-AS780 a	and LGAS780			
Test device is	An identical prototype					
Device category	Portable					
Exposure category	General Population/Ur	ncontrolled Exposure				
Date tested	2/28/2013	2/28/2013				
RF Exposure Rule	Freq. Range	Highest Rep	orted SAR	Category		
22	824-849 MHz	Max. E-Field emissions: 61 Max. H-Field emissions: 0.		M4		
24	1850-1910 MHz	Max. E-Field emissions: 31 Max. H-Field emissions: 0.		M4		
27	1710~1755 MHz	Max. E-Field emissions: 27.25V/m Max. H-Field emissions: 0.085V/m				
Applicable Standards			Test Results	·		
ANSI C63.19-2007			Pass			

Compliance Certification Services, Inc. (UL CCS) tested the above equipment in accordance with the requirements set forth in the above standards. All indications of Pass/Fail in this report are opinions expressed by UL CCS based on interpretations and/or observations of test results. Measurement Uncertainties were not taken into account and are published for informational purposes only. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

Note: The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. This document may not be altered or revised in any way unless done so by UL CCS and all revisions are duly noted in the revisions section. Any alteration of this document not carried out by UL CCS will constitute fraud and shall nullify the document. This report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, any agency of the Federal Government, or any agency of any government (NIST Handbook 150, Annex A). This report is written to support regulatory compliance of the applicable standards stated above.

Prepared By:

Sunay Shih Down Chang

Sunny Shih Devin Chang
Engineering Leader SAR Engineer
UL CCS UL CCS

Approved & Released For UL CCS By:

2. Test Methodology

The tests documented in this report were performed in accordance with ANSI C63.19-2007 Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids and FCC KDB 285076 D01 HAC Guidance v02r01

3. Facilities and Accreditation

The test sites and measurement facilities used to collect data are located at 47173 Benicia Street, Fremont, California, USA.

UL CCS is accredited by NVLAP, Laboratory Code 200065-0. The full scope of accreditation can be viewed at http://www.ccsemc.com.

4. Calibration and Uncertainty

4.1. Measuring Instrument Calibration

The measuring equipment utilized to perform the tests documented in this report has been calibrated in accordance with the manufacturer's recommendations, and is traceable to recognized national standards.

Name of Equipment	Manufacturer	Type/Model	Serial No.	Cal. Due date		
Name of Equipment	Manuacturei	i ype/iviodei	Seriai No.	MM	DD	Year
Synthesized Signal Generator	HP	8665B	3744A01084	5	3	2013
Power Meter	HP	438A	3513U04320	9	17	2013
Power Sensor A	HP	8481A	2237A31744	8	17	2013
Power Sensor B	HP	8481A	3318A95392	8	17	2013
Amplifier	MITEQ	4D00400600-50-30P	1622052		N/A	\
Directional coupler	Werlatone	C8060-102	2149	N/A		١
Robot - Six Axes	Stäubli	TX90 XL	N/A		N/A	١
Robot Remote Control	Stäubli	CS8C	N/A		N/A	١
DASY5 Measurement Server	SPEAG	SEUMS001BA	1041		N/A	١
Probe Alignment Unit	SPEAG	LB (V2)	261		N/A	١
Radio Communication Tester	R &S	CMU 200	106301	6	6	2013
Data Acquisition Electronics	SPEAG	DAE4	1239	6	6	2013
E-Field Probe	SPEAG	ER3DV6	2339	1	11	2014
H-Field Probe	SPEAG	H3DV6	6157	1	11	2014
Calibration Dipole	SPEAG	CD835V3	1014	2	12	2014
Calibration Dipole	SPEAG	CD1880V3	1122	2	12	2014

4.2. Measurement Uncertainty

HAC Uncertainty Budget According to ANSI PC63.19

Error Description	Uncertainty	Probe Dist.	Div.	(Ci) E	(Ci) H	Std. Ur	nc.(?)
End Beschphon	value (?)	1 TODE DISt.	DIV.	(01) L	(01) 11	Е	Н
Measurement System							
Probe Calibration	5.10	N	1	1	1	5.1	5.1
Axial Isotropy	4.70	R	1.732	1	1	2.7	2.7
Sensor Displacement	16.50	R	1.732	1	0.145	9.5	1.4
Boundary Effects	2.40	R	1.732	1	1	1.4	1.4
Linearity	4.70	R	1.732	1	1	2.7	2.7
Scaling to Peak Envelope Power	2.00	R	1.732	1	1	1.2	1.2
System Detection Limit	1.00	R	1.732	1	1	0.6	0.6
Readout Electronics	0.30	N	1	1	1	0.3	0.3
Response Time	0.80	R	1.732	1	1	0.5	0.5
Integration Time	2.60	R	1.732	1	1	1.5	1.5
RF Ambient Conditions	3.00	R	1.732	1	1	1.7	1.7
RF Reflections	12.00	R	1.732	1	1	6.9	6.9
Probe Positioner	1.20	R	1.732	1	0.67	0.7	0.5
Probe Positioning	4.70	R	1.732	1	0.67	2.7	1.8
Extrapolation and Interpolation	1.00	R	1.732	1	1	0.6	0.6
Test sample Related							
Test Positioning Vertical	4.70	R	1.732	1	0.67	2.7	1.8
Test Positioning Lateral	1.00	R	1.732	1	1	0.6	0.6
Device Holder and Phantom	2.40	R	1.732	1	1	1.4	1.4
Power Drift	5.00	R	1.732	1	1	2.9	2.9
Phantom and Setup Related							
Phantom Thickness	2.40	R	1.732	1	0.67	1.4	0.9
Combined Std. Uncertainty			_			14.7	10.9
Expanded Std. Uncertainty on Power						29.4	21.8
Expanded Std. Uncertainty on Field						14.7	10.9

Notesfor table

^{1.} N - Nomal

^{2.} R - Rectangular

^{3.} Div. - Divisor used to obtain standard uncertainty

^{4.} Ci - is te sensitivity coefficient

5. Device Under Test

LTE Phone Bluetooth and WLAN Model US780, LG-US780, LGUS780 AS780, LG-AS780 and LGAS780			
Normal operation:	Held to head		
Accessory:	Standard Battery Cover		

5.1. List of Air Interfaces/Bands & Operating Modes

Air- Interface	Bands (MHz)	Туре	C63.19/ Tested	Simultaneous Transmissions Note: Not to be tested	Concurrent single transmission	Reduced power 20.19 (c) (1)	Voice Over Digital Transport (Data)		
	BC0							,,	
CDMA	BC1	VO	Yes	Yes CDMA, WiFi or Bluetooth	Yes CDMA, WiFi or Bluetooth	Yes: **SVLTE mode only	N/A		
CDMA -	BC15					mede emy			
	EV-DO	DT	N/A	Yes CDMA, WiFi or Bluetooth	Yes: * see note	N/A	N/A		
	Band 2	DT	N/A		Yes: * see note	Yes: **SVLTE mode only			
	Band 4	DT	N/A						
LTE	Band 5	DT	N/A	Yes CDMA, WiFi or Bluetooth			Yes		
	Band 12	DT	N/A						
	Band 25	DT	N/A						
\A/:F:	2450	DT	N/A	Yes	N/A	N/A	Voo		
WiFi	5000	וט	IWA	CDMA or LTE	IV/A	IN/A	Yes		
Bluetooth	2400	DT	N/A	Yes CDMA or LTE	N/A	N/A	N/A		

VO Voice CMRS/PTSN Service Only. V/D Voice CMRS/PSTN and Data Service. DT Digital Transport. Note: * HAC Rating was not base on concurrent voice and data modes, Noncurrent mode was found to represent worst case rating. For M rating.

Note: ** SVLTE: CDMA voice and LTE Simultaneously transmission.

6. System Specifications

E-field and H-field measurements are performed using the DASY5 automated dosimetric assessment system. The DASY5 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland.

The DASY5 HAC Extension consists of the following parts:

Test Arch Phantom

The specially designed Test Arch allows high precision positioning of both the device and any of the validation dipoles.

ER3DV6 Isotropic E-Field Probe

Construction: One dipole parallel, two dipoles normal to probe axis Built-in shielding against static

charges PEEK enclosure material (resistant to organic solvents, e.g., glycolether)

Calibration: In air from 100 MHz to 3.0 GHz (absolute accuracy ±6.0%, k=2)

Frequency: 100 MHz to > 6 GHz; Linearity: ± 0.2 dB (100 MHz to 3 GHz)

Directivity: \pm 0.2 dB in air (rotation around probe axis)

± 0.4 dB in air (rotation normal to probe axis)

Dynamic Range: 2 V/m to > 1000 V/m; Linearity: ± 0.2 dB

Dimensions: Overall length: 330 mm (Tip: 16 mm)

Tip diameter: 8 mm (Body: 12 mm)

Distance from probe tip to dipole centers: 2.5 mm

The closest part of the sensor element is 1.1 mm closer to the tip

Application: General near-field measurements up to 6 GHz

Field component measurements

H3DV6 3-Dimensional H-Field Probe

Construction: Three concentric loop sensors with 3.8 mm loop diameters resistively loaded detector

diodes for linear response Built-in shielding against static charges PEEK enclosure

material (resistant to organic solvents, e.g., glycolether)

Frequency: 200 MHz to 3 GHz (absolute accuracy ± 6.0%, k=2); Output linearized

Directivity: $\pm 0.25 \text{ dB (spherical isotropy error)}$

Dynamic Range: 10 mA/m to 2 A/m at 1 GHz

E-Field Interference: < 10% at 3 GHz (for plane wave)

Dimensions: Overall length: 330 mm (Tip: 40 mm)
Tip diameter: 6 mm (Body: 12 mm)

Distance from probe tip to dipole centers: 3 mm

The closest part of the sensor element is 1.9 mm closer to the tip

Application: General magnetic near-field measurements up to 3 GHz

Field component measurements Surface current measurements Measurements in air or liquids

Low interaction with the measured field

7. System Validation

The test setup was validated when first configured and verified periodically thereafter to ensure proper function. The procedure provided in this section is a validation procedure using dipole antennas for which the field levels were computed by numeric modeling.

Procedure

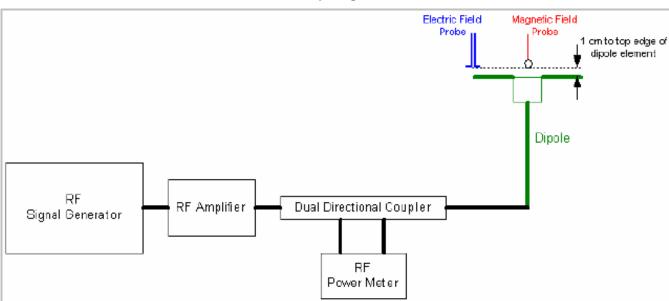
Place a dipole antenna meeting the requirements given in ANSI-PC63.19 2007 in the normally occupied by the WD.

The dipole antenna serves as a known source for an electrical and magnetic output. Position the E-field and H-field probes so that:

- The probes and their cables are parallel to the coaxial feed of the dipole antenna
- The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions; and
- The center point of the probe element(s) are 10 mm from the closest surface of the dipole elements.

Scan the length of the dipole with both E-field and H-field probes and record the maximum values for each. Compare the readings to expected values.

Setup diagram



UL CCS FORM NO: CCSUP4031C 47173 BENICIA STREET, FREMONT, CA 94538, USA TEL: (510) 771-1000 FAX: (510) 661-0888

7.1. System Validation Results

E-field

			Max. mea	sured from	Average max.	E-field Target	
Calibration Dipole	f (MHz)	Input Power (mW)	above high end (V/m)	above low end (V/m)	above arm (V/m)	Values (V/m) (From SPEAG)	Deviation ¹⁾ (%)
CD835V3 SN 1014	835	100	164.7	159.8	162.25	161.8	0.28
CD1880V3 SN 1122	1730	100	148.9	157.4	153.15	151.15	1.32
CD1880V3 SN 1122	1880	100	132.6	136.7	134.65	139.4	-3.41

H-field

Calibration Dipole	f (MHz)	Input Power (mW)	Measured H-field (A/m)	H-field Target Values (A/m) (From SPEAG)	Deviation ¹⁾ (%)
CD835V3 SN 1014	835	100	0.465	0.459	1.31
CD1880V3 SN 1122	1730	100	0.476	0.493	-3.45
CD1880V3 SN 1122	1880	100	0.468	0.461	1.52

Notes:

- 1) Delta (Deviation) % = 100 * (Measured value minus Target value) divided by the Target value. Deltas within ±25% are acceptable, of which 12% is deviation and 13% is measurement uncertainty.
- 2) The maximum E-field or H-field were evaluated and compared to the target values provided by SPEAG in the calibration certificate of specific dipoles.
- 3) Please refer to the attachment for detailed measurement data and plots.

8. Probe Modulation Factor (PMF)

Purpose

The HAC Standard requires measurement of the peak envelope E- and H-fields of the wireless device (WD). Para. 4.2.2.1, and C.3.1 of the standard describes the Probe Modulation Response Factor that shall be applied to convert the probe reading to Peak Envelope Field.

Definitions

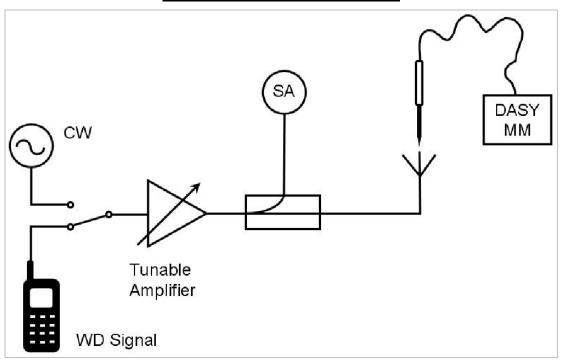
The Probe Modulation Factor (PMF) is defined as the ratio of the field readings for a CW and a modulated signal with the equivalent Field Envelope Peak as defined in the Standard (Chapter C.3.1).

Evaluation Procedure for Unknown PMF (DASY4 Application note, Section 28.8)

The proposed measurement setup corresponds to the procedure as required in the Standard, Chapter C.3.1.

- 1. Install a calibration dipole for the appropriate frequency band under the Test Arch Phantom and select the proper phantom section according to the probe type installed (E- or H-field). Move the probe to the field reference point. (Do not move the probe between the subsequent CW and modulated measurements.)
- 2. Install the field probe in the setup.
- 3. The modulated signal to the dipole must be monitored to record peak amplitude and compared to a CW signal with the same peak envelope level (e.g., with a directional coupler and a spectrum analyzer in zero span mode set to the operating frequency). To determine the peak envelope level of the modulated signal properly, the settings of a spectrum analyzer shall be as follows:
 - Resolution bandwidth >= emission bandwidth (4 MHz for UMTS bands, 300 kHz)
 - Video bandwidth >= 20 kHz
 - Span: zero
 - Center Frequency: nominal center frequency of channel
 - Detection: RMS detection with averaging turned on
 - Trigger: Video or IF trigger, adjusted to give a stable display of the transmission
 - Sweep rate: Sufficiently rapid to permit the transmit pulse to be resolved accurately. The sweep shall be long enough to show a complete transmission. The sweep time may be set to allow a full transmission cycle, displaying the on and off time.
- 4. Define a DASY4 document and set the procedure properties (frequency, modulation frequency and crest factor) according to the measured signal. Define a multimeter job for the field reading.
- 5. Define a second procedure for the evaluation of the CW signal (frequency set as above, modulation frequency = 0, crest factor = 1) and a multimeter job.

PMF Measurement Setup Diagram



The HAC measurement procedure is as follows:

- Modulated signals (WD and 80% AM) measurement:
 - 1) Connect the modulated signal using the appropriate frequency via the cable to the dipole.
 - The signal to the dipole must be monitored to record peak amplitude with a directional coupler and a spectrum analyzer.
 - 3) Run the multimeter job in the procedure with the corresponding modulation setting in continuous mode.
 - 4) Read the envelope peak on the monitor in order to adjust the CW signal later to the same level.
- CW signal measurement:
 - Change the signal to CW at the same center frequency, without touching or moving the dipole and probe in the setup.
 - Adjust the CW signal amplitude to the same peak level on the spectrum analyzer (keep the same bandwidth and attenuation for CW and modulated signals).
 - 3) Run the multimeter job in the CW procedure in continuous mode.
 - 4) Read the multimeter total field display and note it together with modulation type and frequency.
 - 5) Calculate the Probe Modulation Factor as the ratio between the CW multimeter field reading and the reading for the applicable modulation. I.e., $PMF = \frac{E_{cw}}{E_{mod}}$ and similar for H.

8.1. PMF Measurement Results

CDMA

Probe	Frequency (MHz)	Type of signal	E-field V/m	PMF	
	835	CDMA (RC3/SO55)	64.6	0.95	
	033	CW	61.4	0.95	
E-Field Probe	1730	CDMA (RC3/SO55)	45.2	0.96	
L-Heid Flobe	1730	CW	43.2	0.90	
	1880	CDMA (RC3/SO55)	44.7	0.95	
		CW	42.6	0.93	
Probe	Frequency (MHz)	Type of signal	H-field A/m	PMF	
	835	CDMA (RC3/SO55)	0.260	0.96	
	033	CW	0.249	0.90	
H-Field Probe	1730	CDMA (RC3/SO55)	0.196	0.96	
	1730	CW	0.188	0.90	
	1880	CDMA (RC3/SO55)	0.190	0.98	
	1000	CW	0.187	0.96	

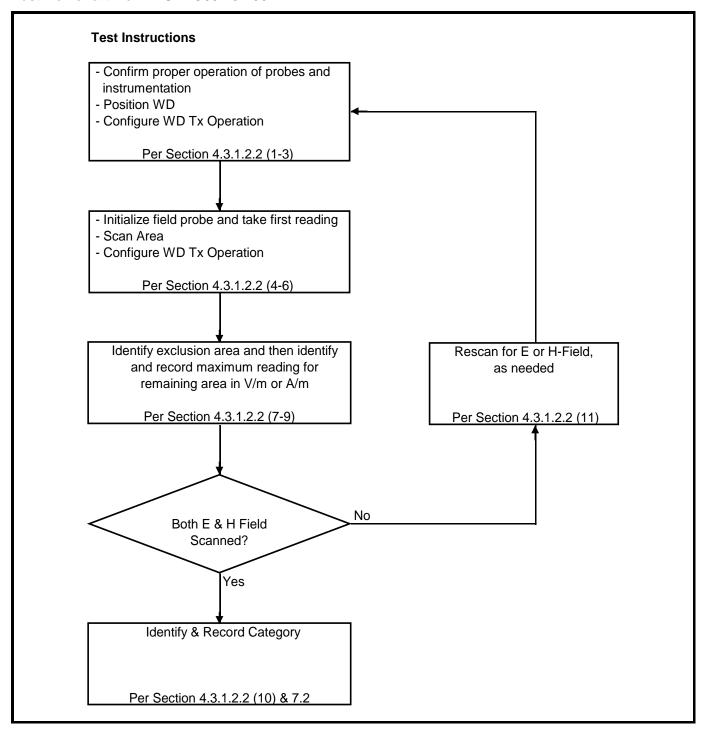
9. HAC RF Emissions Test Procedure

The following are step-by-step test procedures.

- Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
- 2. Position the WD in its intended test position.
- 3. Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters, (e.g. test mode) as intended for the test.
- 4. The center sub-grid shall be centered on the center of the WD output (acoustic or T-coil output), as appropriate. Locate the field probe at the initial test position in the 5 x 5 cm grid, which is contained in the measurement plane, see illustrated in Figure 5.
- 5. Record the reading.
- 6. Scan the entire 5 x 5 cm region in equally spaced increments and record the reading at each measurement point. The distance between measurement points shall be sufficient to assure the identification of the peak reading.
- 7. Identify the five contiguous sub-grids around the center sub-grid with the lowest maximum strength readings. Thus the 6 areas to be used to determine the WD's peak emissions are identified and outlined for the final manual scan. Please note that a maximum of five blocks can be excluded for both E- and H-field measurements for the WD output being measured. State another way, the center sub-grid and 3 other must be common to both the E- and H-field measurements.
- 8. Identify the highest field reading within the non-excluded sub-grids identified in step 7.
- 9. Convert the highest field reading within identified in step 8 to peak V/m or A/m, as appropriate.
- 10. Repeat steps 1-10 for both the E- and H-field measurements.
- 11. Compare this reading to the categories in ANSI-PC63.19 and record the resulting category. The lowest category number listed in ANSI-PC63.19 obtained in step 10 for either E or H field determines the M category for the audio coupling mode assessment. Record the WD category rating.

Page 15 of 25

Test flowchart Per ANSI-PC63.19 2007



10. RF Emissions Measurement Criteria

Telephone near-field Categories in linear units

		Telephone RF Parameters					
		< 960) MHz	> 960) MHz		
		E-Field	H-Field	E-Field	H-Field		
Category	AWF	Emissions (V/m)	Emissions (A/m)	Emissions (V/m)	Emissions (A/m)		
M3	0	199.5 to 354.8	0.60 to 1.07	63.1 to 112.2	0.19 to 0.34		
IVIO	-5	149.6 to 266.1	0.45 to 0.80	47.3 to 84.1	0.14 to 0.25		
M4	0	< 199.5	< 0.60	< 63.1	< 0.19		
1714	-5	< 149.6	< 0.45	< 47.3	< 0.14		

HAC (RF Emissions) Test Results

10.1. E-Field Emissions

Operating Mode	Ch. No.	Freg. (MHz)	Peak E-Field (V/m)	M-Rating
CDMA BC0	1013	824.7	61.27	M4
1xRTT	384	836.6	56.96	M4
(RC3, SO55)	777	848.31	51.99	M4
CDMA BC1	25	1851.25	27.31	M4
1xRTT	600	1880.0	28.49	M4
(RC3, SO55)	1175	1908.75	31.71	M4
CDMA BC15	25	1711.25	22.96	M4
1xRTT	450	1732.50	24.90	M4
(RC3, SO55)	875	1753.75	27.25	M4

10.2. H- Field Emissions

		_	Peak	
Operating Mode	Ch. No.	Freq. (MHz)	H-Field (A/m)	M-Rating
CDMA BC0	1013	824.7	0.084	M4
1xRTT	384	836.6	0.080	M4
(RC3, SO55)	777	848.31	0.080	M4
CDMA BC1	25	1851.25	0.081	M4
1xRTT	600	1880.0	0.086	M4
(RC3, SO55)	1175	1908.75	0.096	M4
CDMA BC15	25	1711.25	0.074	M4
1xRTT	450	1732.50	0.075	M4
(RC3, SO55)	875	1753.75	0.085	M4

11. Worst-case Test Plots

E-field worst-cast test plot for Part 22

Test Laboratory: UL CCS SAR Lab C Date: 2/28/2013

HAC-RF Emission

Communication System: CDMA2000; Frequency: 824.7 MHz; Duty Cycle: 1:1

Phantom section: RF Section

DASY5 Configuration:

- Probe: ER3DV6 - SN2339; ConvF(1, 1, 1); Calibrated: 1/11/2013;

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn1239; Calibrated: 6/6/2012

- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA

- Measurement SW: DASY52, Version 52.8 (5); SEMCAD X Version 14.6.8 (7028)

CDMA BC0 (E-field scan for ANSI C63.19-2007 compliance)/RC3 SO55_ch 1013/Hearing Aid Compatibility Test

(101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 80.82 V/m; Power Drift = -0.10 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 61.27 V/m Near-field category: M4 (AWF 0 dB)

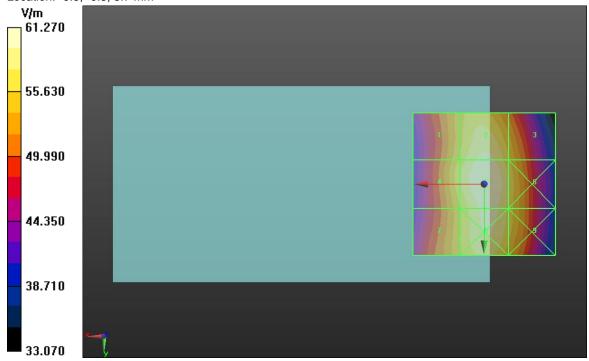
PMF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
56.09 V/m	60.00 V/m	56.14 V/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
57.32 V/m	61.27 V/m	57.56 V/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
55.56 V/m	60.08 V/m	57.13 V/m

Cursor:

Total = 61.27 V/m E Category: M4

Location: -0.5, -0.5, 8.7 mm



Page 18 of 25

E-field worst-cast test plot for Part 24

Test Laboratory: UL CCS SAR Lab C Date: 2/28/2013

HAC-RF Emission

Communication System: CDMA2000; Frequency: 1908.75 MHz; Duty Cycle: 1:1

Phantom section: RF Section

DASY5 Configuration:

- Probe: ER3DV6 SN2339; ConvF(1, 1, 1); Calibrated: 1/11/2013;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1239; Calibrated: 6/6/2012
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA
- Measurement SW: DASY52, Version 52.8 (5); SEMCAD X Version 14.6.8 (7028)

CDMA BC1 (E-field scan for ANSI C63.19-2007 compliance)/RC3 SO55_ch 1175/Hearing Aid Compatibility Test

(101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 29.01 V/m; Power Drift = 0.07 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 31.71 V/m

Near-field category: M4 (AWF 0 dB)

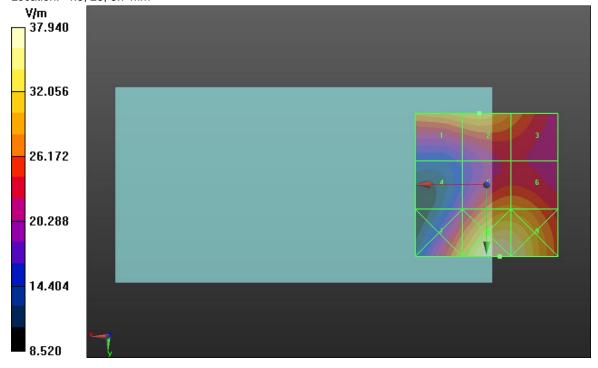
PMF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
31.23 V/m	31.71 V/m	28.22 V/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
20.38 V/m	29.26 V/m	29.15 V/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
30.60 V/m	37.94 V/m	36.95 V/m

Cursor:

Total = 37.94 V/m E Category: M4

Location: -4.5, 25, 8.7 mm



E-field worst-cast test plot for Part 90

Test Laboratory: UL CCS SAR Lab C Date: 2/28/2013

HAC-RF Emission

Communication System: CDMA2000; Frequency: 1753.75 MHz; Duty Cycle: 1:1

Phantom section: RF Section

DASY5 Configuration:

- Probe: ER3DV6 SN2339; ConvF(1, 1, 1); Calibrated: 1/11/2013;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1239; Calibrated: 6/6/2012
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA
- Measurement SW: DASY52, Version 52.8 (5); SEMCAD X Version 14.6.8 (7028)

CDMA BC15 (E-field scan for ANSI C63.19-2007 compliance)/RC3 SO55_ch 875/Hearing Aid Compatibility Test

(101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 24.76 V/m; Power Drift = 0.02 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 27.25 V/m

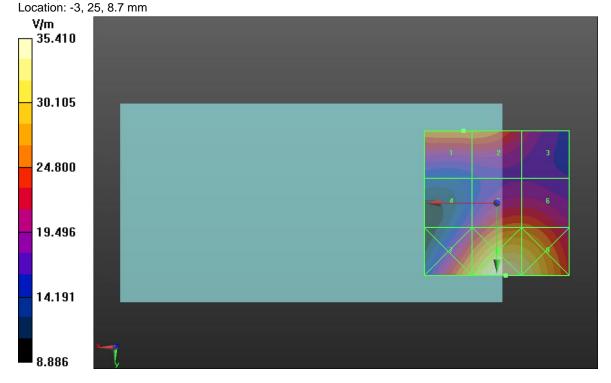
Near-field category: M4 (AWF 0 dB)

PMF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
27.25 V/m	27.16 V/m	21.14 V/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
19.51 V/m	25.98 V/m	25.90 V/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
29.95 V/m	35.41 V/m	34.14 V/m

Cursor:

Total = 35.41 V/m E Category: M4



H-field worst-cast test plot for Part 22

Test Laboratory: UL CCS SAR Lab C Date: 2/28/2013

HAC-RF Emission

Communication System: CDMA2000; Frequency: 824.7 MHz; Duty Cycle: 1:1

Phantom section: RF Section

DASY5 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 1/11/2013

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn1239; Calibrated: 6/6/2012

- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA

- Measurement SW: DASY52, Version 52.8 (5); SEMCAD X Version 14.6.8 (7028)

CDMA BC0 (H-field scan for ANSI C63.19-2007 compliance)/RC3 SO55_ch 1013/Hearing Aid Compatibility Test

(101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.05900 A/m; Power Drift = 0.01 dB

PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.08373 A/m Near-field category: M4 (AWF 0 dB)

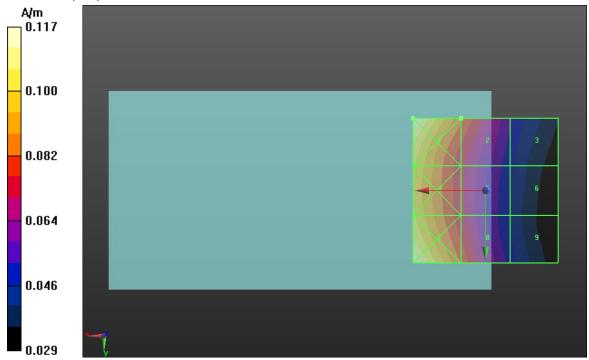
PMF scaled H-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
0.117 A/m	0.084 A/m	0.054 A/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
0.101 A/m	0.073 A/m	0.048 A/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
0.117 A/m	0.082 A/m	0.050 A/m

Cursor:

Total = 0.1173 A/m H Category: M4

Location: 25, -25, 8.7 mm



This report shall not be reproduced except in full, without the written approval of UL CCS.

H-field worst-cast test plot for Part 24

Date: 2/28/2013

Test Laboratory: UL CCS SAR Lab C

HAC-RF Emission

Communication System: CDMA2000; Frequency: 1908.75 MHz; Duty Cycle: 1:1

Phantom section: RF Section

DASY5 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 1/11/2013

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn1239; Calibrated: 6/6/2012

- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA

- Measurement SW: DASY52, Version 52.8 (5); SEMCAD X Version 14.6.8 (7028)

CDMA BC1 (H-field scan for ANSI C63.19-2007 compliance)/RC3 SO55_ch 1175/Hearing Aid Compatibility Test

(101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.1140 A/m; Power Drift = -0.08 dB

PMR not calibrated. PMF = 1.000 is applied.

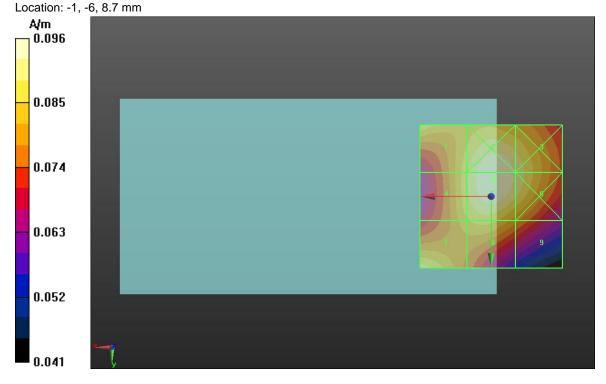
H-field emissions = 0.09587 A/m
Near-field category: M4 (AWF 0 dB)

PMF scaled H-field

Grid 1 M4 0.090 A/m	
Grid 4 M4 0.088 A/m	
Grid 7 M4 0.091 A/m	

Cursor:

Total = 0.09587 A/m H Category: M4



H-field worst-cast test plot for Part 90

Test Laboratory: UL CCS SAR Lab C

Date: 2/28/2013

HAC-RF Emission

Communication System: CDMA2000; Frequency: 1753.75 MHz; Duty Cycle: 1:1

Phantom section: RF Section

DASY5 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 1/11/2013

- Sensor-Surface: (Fix Surface)

- Electronics: DAE4 Sn1239; Calibrated: 6/6/2012

- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA

- Measurement SW: DASY52, Version 52.8 (5); SEMCAD X Version 14.6.8 (7028)

CDMA BC15 (H-field scan for ANSI C63.19-2007 compliance)/RC3 SO55_ch 875/Hearing Aid Compatibility Test

(101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.1010 A/m; Power Drift = -0.01 dB

PMR not calibrated. PMF = 1.000 is applied.

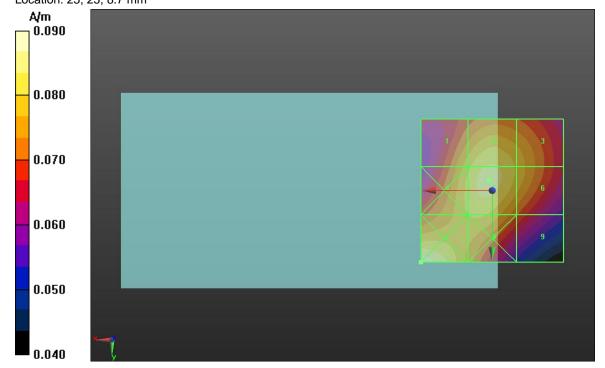
H-field emissions = 0.08498 A/m
Near-field category: M4 (AWF 0 dB)

PMF scaled H-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
0.079 A/m	0.084 A/m	0.080 A/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
0.081 A/m	0.085 A/m	0.080 A/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
0.090 A/m	0.081 A/m	0.071 A/m

Cursor:

Total = 0.09029 A/m H Category: M4 Location: 25, 25, 8.7 mm



12. Appendixes

Refer to separated files for the following appendixes

- 12.1. System Validation Plots
- 12.2. E-field emissions test plots
- 12.3. H-field emissions test plots
- 12.4. Calibration Certificate for E-Field Probe ER3DV6 SN 2339
- 12.5. Calibration Certificate for H-Field Probe H3DV6 SN 6157
- 12.6. Calibration Certificate for Dipole CD835V3 SN 1014
- 12.7. Calibration Certificate for Dipole CD1880V3 SN 1122